

# Data Quality and Time Synchronization

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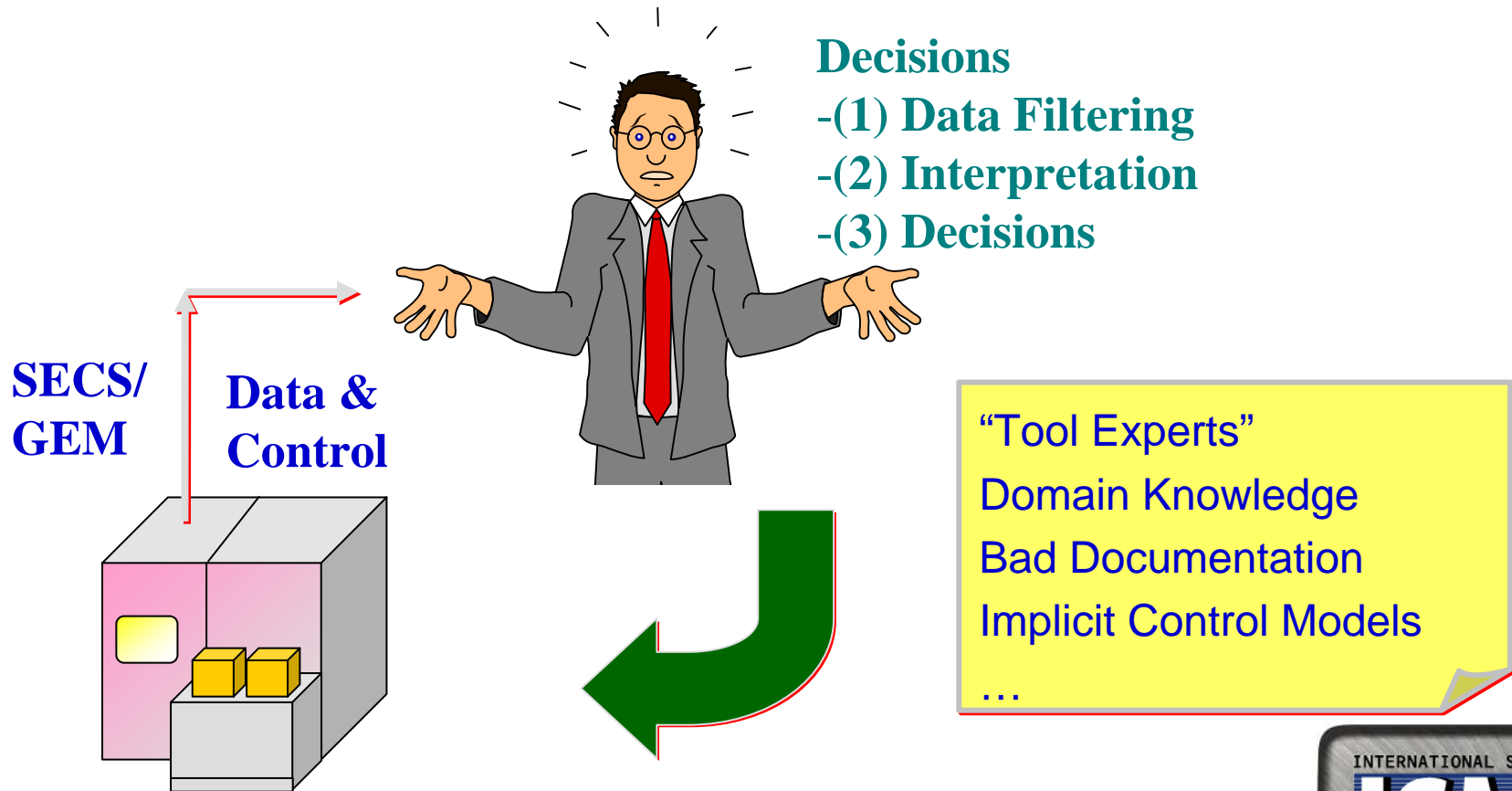


# Outline

- **Data Quality Background**
- **Member Company Experiences**
- **Time Synchronization**
  - **Background**
  - **Standards Ballot**
    - **Key Features**
  - **Guidelines**
    - **Timing Matrix**
- **Data Quality Key Messages**

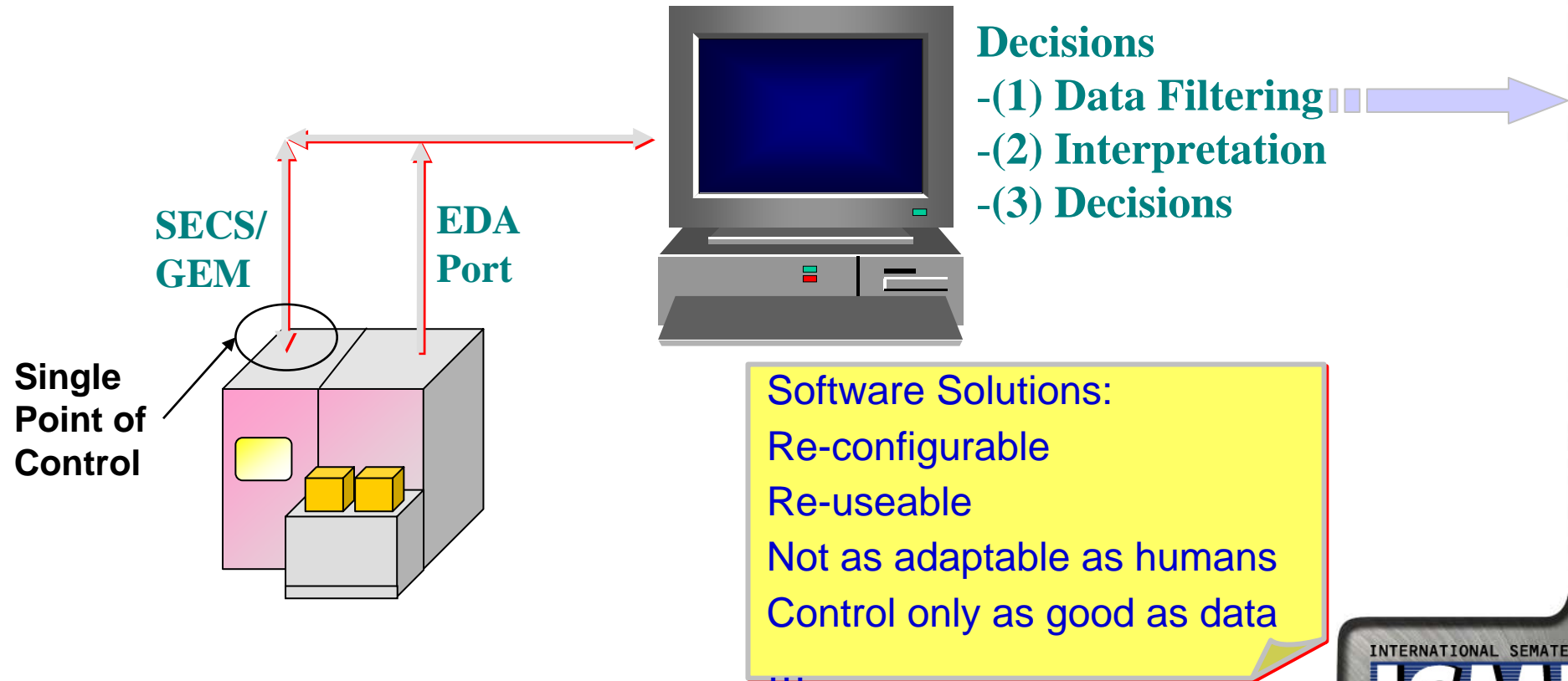
# Data Quality Introduction

- In the **past**, humans interpreted tool output
  - **Complex and very adaptable minds**



# Data Quality Introduction

- We are moving towards automated data filtering, interpretation, and control



# Data Quality and Time Synchronization Background

- **Background**

- As the industry moves toward e-Manufacturing, the data each tool generates is critical to improve equipment productivity
- Today, the quality of data is poor; it must be dramatically improved if applications are to effectively apply collected data
- Message integrity, data accuracy, data resolution, sensor data calibration, data transmission rates, proper triggering, and data noise filtering must all be accurate, reliable, timely, and complete

- **Challenge in the past to reach agreement on data quality definitions**

- Today, leverage definitions from standard sources, e.g., NIST, ISO, IEEE for Time Synchronization

- **SEMI Time Synchronization Working Group membership**

- IC makers and sensor/equipment/software suppliers
- To participate, contact:  
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# Equipment Data Quality Principles

- **Data must be provided with sufficient accuracy, resolution, and sampling frequency to allow high fidelity extraction of relevant data features for process/equipment characterization, fault detection, failure diagnosis, and process control.**
- **Event data and context information must be complete, consistent, and correct as well as reflect the actual time of and conditions pertaining to the occurrence of the indicated event.**
- **Timely transfer of data is necessary to achieve fault interdiction.**
- **All data streams provided by the equipment must be complete, consistent, timely, accurate, and properly sampled and possess high enough resolution to serve their intended purposes.**

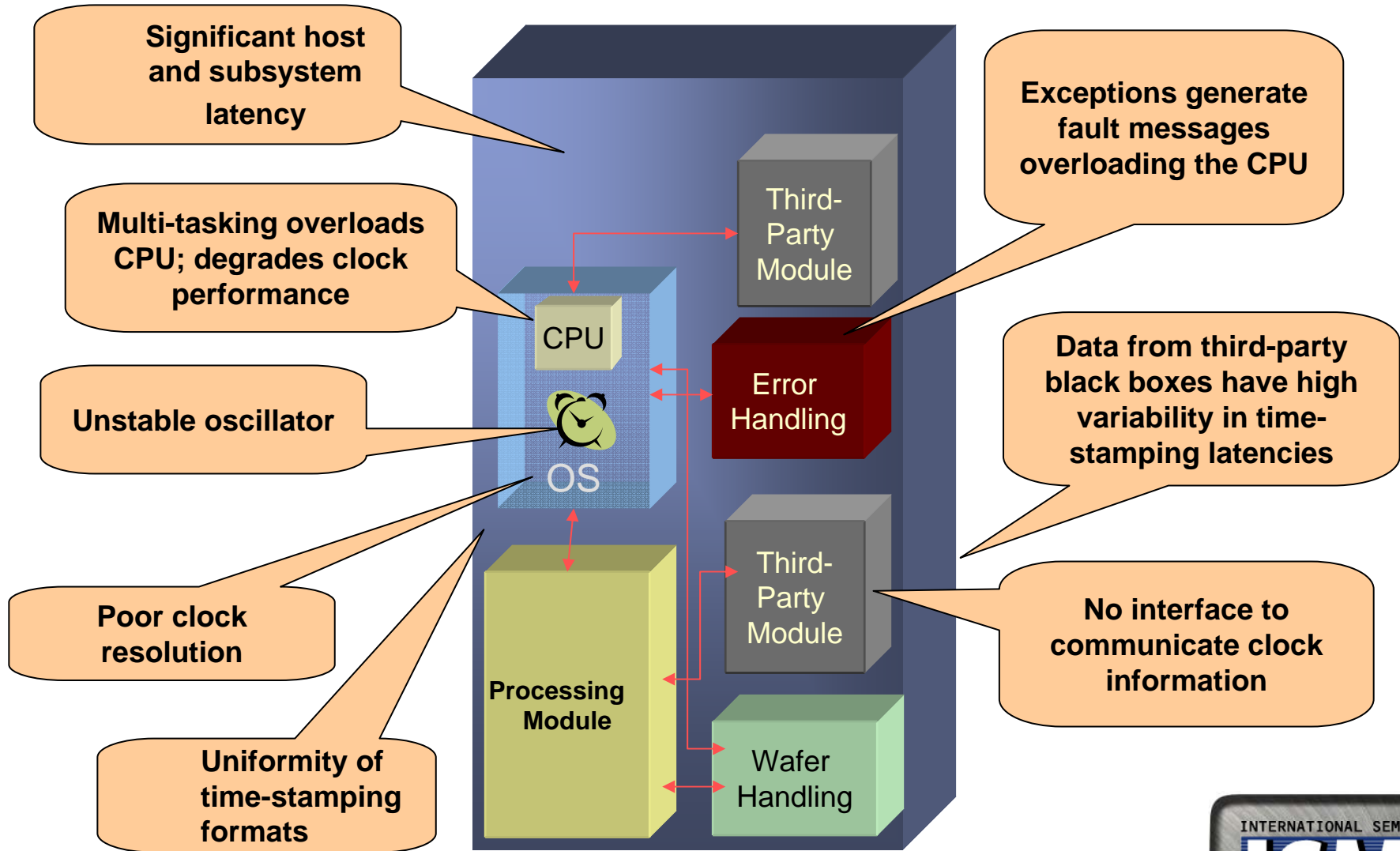


# IC Maker Consensus Experiences

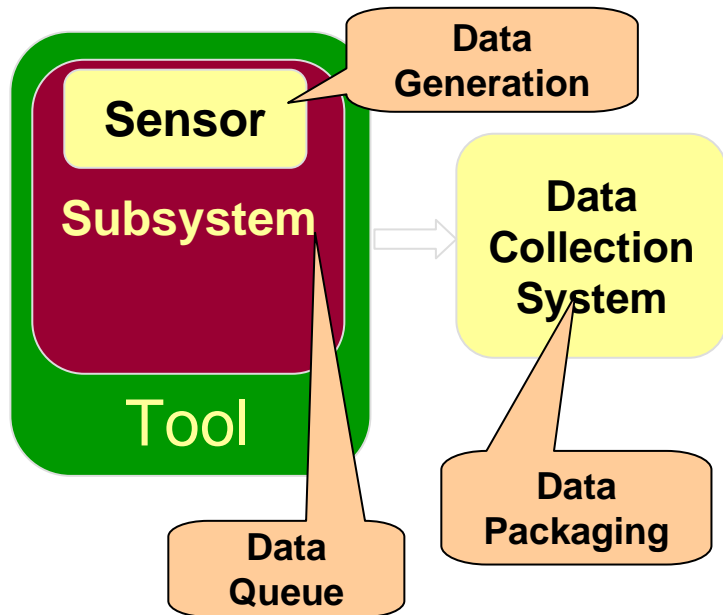
- **Issues Experienced**

- Equipment interface has software defects
- Documentation does not match software
- Reports send wrong format of data
- Equipment performance affected by data collection
  - **Resulting in lost data**
- Short data collection period with a high rate can take tool down
  - **Resulting in product loss**
- Missing data, including context data
- Reporting not current data
- Data report and event latency
- Inaccurate error reporting
- Unclear level of data collection limits, without affecting process
  - **Not clear what the equipment is capable off**
- Context data missing, e.g., linking data with a wafer
- Incorrect decisions made due to missing events or missing data
- Non-existent time synchronization
  - **Data reports cannot be used to correlate events, alarms, or process issues**

# Time Synch Issues: Equipment



# Time Synch Issues: Data Time Stamps

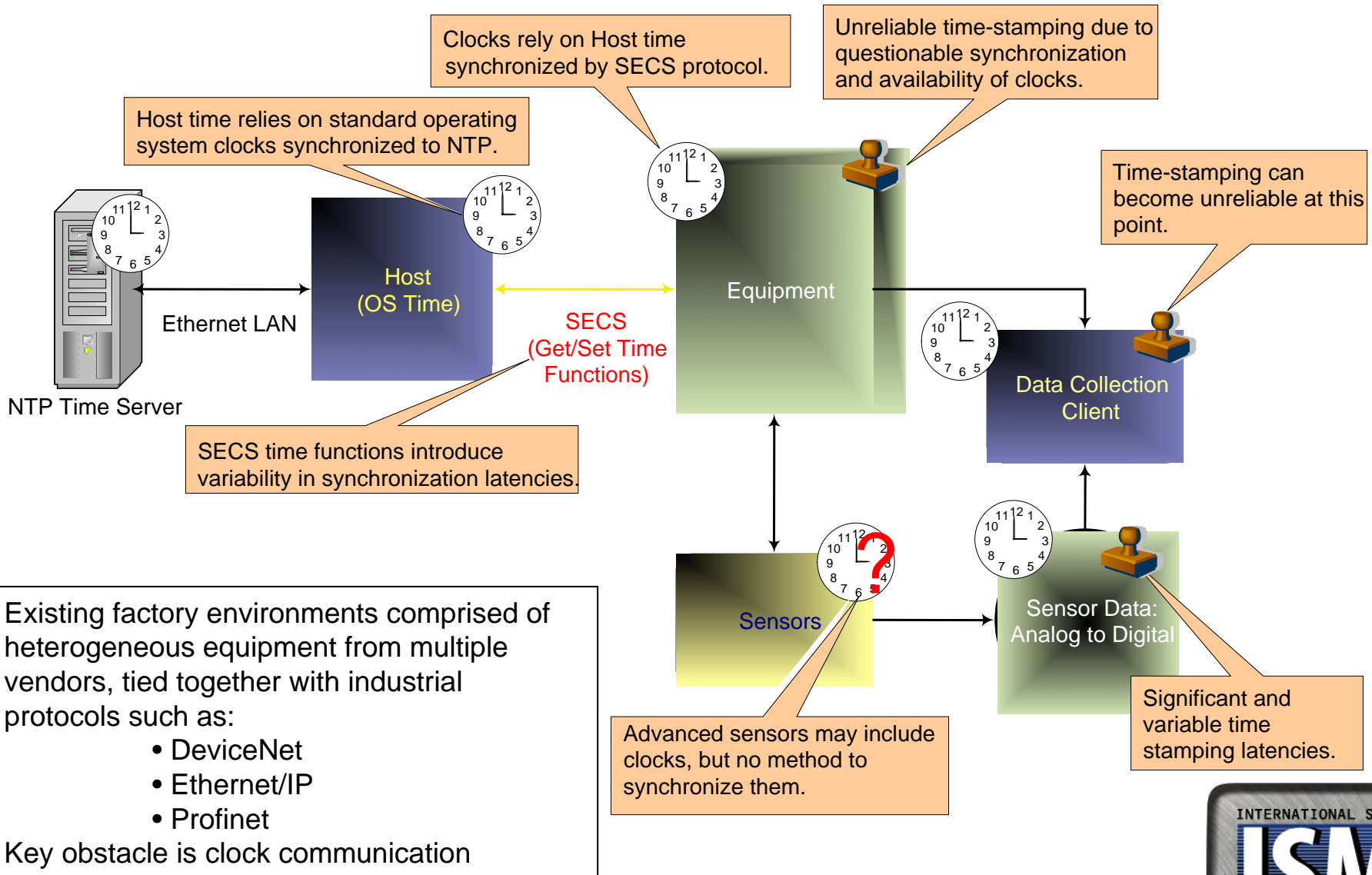


Possible Time-stamping Points

**Time-stamping latencies within a single tool due to inconsistencies:**

- **Format/time reference**
- **Point of time-stamping**
  - **Should reflect time of data generation**
  - **Should not include**
    - **Transmission time**
    - **Processing**
    - **Queuing time**

# Issues: Factory Synchronization



# Time Synchronization Working Group

## Mission:

To encourage/require accurate equipment and factory clock synchronization for future implementations, while maintaining compatibility with legacy systems

## Goals:

- Define what THE master clock is
- Factory clock synchronization precision
- Embedded clocks within equipment need to be synchronized with factory clock
- Factory applications timing requirements
- Common time-stamp format/basis
- Consistent point of time-stamping
- Time-stamp traceability/quality for verification
- Facilitate data merging

# Time Synchronization Approach

## 1. Publish Time Synchronization Guidelines

- **Characterized processes for timing accuracy and precision requirements**

## 2. Specifications in new standard

- **Ballot (4291) submitted for Cycle 4**

## 3. Update existing standards to support time synchronization/time-stamping

- **E5, E30, E....,**
- ***Backward compatibility is an absolute requirement***

# Draft Time Synchronization Guidelines Document Outline

- 1 BACKGROUND
  - 2 REFERENCES
  - 3 TERMINOLOGY
    - 3.1 Definitions
    - 3.2 Acronyms
  - 4 TIME SYNCHRONIZATION GUIDELINES
    - 4.1 UTC Time Scale
    - 4.2 Factory Time Servers
    - 4.3 Time Synchronization Traceability
    - 4.4 Fault Tolerance
    - 4.5 Traceable Reference Time Source
    - 4.6 Distributed Clock Synchronization
    - 4.7 Time Synchronization Clients (Device Clocks)
    - 4.8 Time Synchronization Architecture
    - 4.9 Clock Quality
    - 4.10 Clock Resolution
    - 4.11 Time Synchronization Frequency
    - 4.12 Network Jitter
    - 4.13 Monitoring Synchronization Quality
    - 4.14 Security
    - 4.15 Data Time Stamping Guidelines
- APPENDIX A – ACCURACY/PRECISION GUIDELINES FOR e-MANUFACTURING APPLICATIONS

# Application Timing Requirements

## *On-tool Examples*

Application	Description/Needs	Absolute Accuracy	Relative Accuracy	Minimum Data Sampling Interval	Precision Required
<b>Intra-tool Sensor Integration</b>	Connect sensors to embedded tool control system for use in real-time control and/or communication to external applications.	5 sec	5 ms	5 ms	1 ms
<b>End-Point Detection</b>	Analyze key equipment/process parameters to detect the end of a recipe step.	5 sec	10 ms	10 ms	1 ms
<b>In-Situ FDC</b>	Need to correlate sensor data, tool data, and other process data to a specific wafer/lot for multivariate analysis.	5 sec	5 ms	5 ms	1 ms
<b>Integrated Metrology (IM)</b>	Standard calls for synchronized clocks to accurately time stamp metrology data.	5 sec	100 ms	100 ms	1 ms

# Application Timing Requirements

## *Fab-level Examples*

Application	Description/Needs	Absolute Accuracy	Relative Accuracy	Minimum Data Sampling Interval	Precision Required
<b>Real-Time Data Base (EES Data Repository) (Historian)</b>	Provide high-speed storage and retrieval of detailed equipment and process data to support wide range of application needs.	5 sec	10 ms	20 ms	1 ms
<b>Control / Fault Model Development</b>	Analyze equipment, process, metrology, and yield information to development control models used for APC applications.	10 sec	10 ms	1 min	1 ms
<b>Fault Detection and Classification (FDC)</b>	Analyze equipment and process parameters to ensure tool is in its acceptable operating envelope; identify and classify (or prevent) equipment faults and interrupt processing accordingly.	5 sec	10 ms	50 ms (in process) 20 sec (post-process)	1 ms
<b>Event / Alarm Management</b>	Capture, analyze, communicate, and support user response to events and alarms across the production environment.	5 sec	1 sec	1 sec	1 ms
<b>Scheduling/ Dispatching (RTD)</b>	Provides ability to accurately estimate time of completion, arrival of wafers, and to prepare a tool for wafer processing.	5 sec	2 sec	2 sec	1 ms
<b>Factory Time Synchronization</b>	Maintain and provide reference time for all systems in the fab.	5 sec	1 ms	10 sec	1 ms

# Time Synchronization Standard – Balloted Document (4291)

## Specifications in new standard

- Equipment shall support synchronization of all modules with clocks using NTP
- Time-stamping capability required
- Time-stamp reporting format (ISO 8601)
  - Format to be used by other standards
- Time-stamp quality
- Defines a clock object
  - To readily obtain information from equipment:
    - Method to record time latency/uncertainty
    - Clock quality verification
    - Time-stamp

# Summary

- Data from sensors and tools cannot be readily merged today to meet factory application needs
  - Unreliable time-stamps prevent advanced analysis capabilities
  - Clocks within the tools should readily synchronize
    - All tool and tool components' clocks should support synchronization
- Synchronization solutions exist
  - The factory provides accurate timing
    - Time servers and time sources inside the factory should propagate timing information to all equipment and equipment modules using mainstream synchronization protocols
- Standards/guidelines being developed to
  - Improve synchronization communication of equipment clocks
    - Provide consistent time-stamping
  - Verify clock synchronization/time-stamping quality
- Time synchronization is an initial step to addressing the overall data quality issue

# Data Quality West Key Messages

- Data producers are the equipment suppliers; they are the only ones that can improve data quality.
- Data consumers are IC makers, who are at the mercy of the producers; the quality of the decisions made is wholly dependent on the quality of the data. Garbage in, garbage out .
- Data generated by semiconductor equipment is critical to improving equipment and factory productivity .
- Data must be provided with sufficient accuracy, resolution, and sampling frequency for process/ equipment characterization, fault detection, failure diagnosis, and process development/control.
- **How does your organization measure data quality?**
- **What are the costs associated with the lack of data quality?**

# Time Synchronization References

## ISMI Reports

*Using Network Time Protocol (NTP): Introduction and Recommended Practices*

[ismi.sematech.org/docubase/abstracts/4736aeng.htm](http://ismi.sematech.org/docubase/abstracts/4736aeng.htm)

*Semiconductor Factory and Equipment Clock Synchronization for e-Manufacturing*

[ismi.sematech.org/docubase/abstracts/4557aeng.htm](http://ismi.sematech.org/docubase/abstracts/4557aeng.htm)

## ISO 8601:2004

Internet standard for date/time format: [www.w3.org/TR/NOTE-datetime.html](http://www.w3.org/TR/NOTE-datetime.html)

## NTP

[www.ntp.org](http://www.ntp.org)

Latest official NTP RFC 1305: [www.ietf.org/rfc/rfc1305.txt](http://www.ietf.org/rfc/rfc1305.txt)

NTP version 4 Working Draft: [www.ietf.org/internet-drafts/draft-ietf-ntp-ntp4-02.txt](http://www.ietf.org/internet-drafts/draft-ietf-ntp-ntp4-02.txt)

## IEEE 1588

[ieee1588.nist.gov](http://ieee1588.nist.gov)